

IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology 100µm chip
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

This chip is used for:

IGBT Modules

Applications: • drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC121T60NR2C	600V	150A	11 x 11 mm ²	sawn on foil	Q67041-A4684- A001

MECHANICAL PARAMETER:

Raster size	11 x 11	mm ²		
Area total / active	121 / 102.5	1		
Emitter pad size	8 x 6.2 x 2.55			
Gate pad size	1.51 x 0.8			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	106			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1200 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			

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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	450	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_i =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
T drameter	- Cymbei	Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V, I _C =4mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.7	2	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=3mA$, $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V			10.2	μA
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			480	nA
Integrated gate resistor	R _{Gint}			5	7	Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Canditions		Value		
raiailietei		Conditions	min.	typ.	max.	Unit
Input capacitance	Ciss	V _{CE} =25V	-	6500		pF
Output capacitance	Coss	V _{GE} =0V	-	tbd		
Reverse transfer capacitance	Crss	f=1MHz	-	600		

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

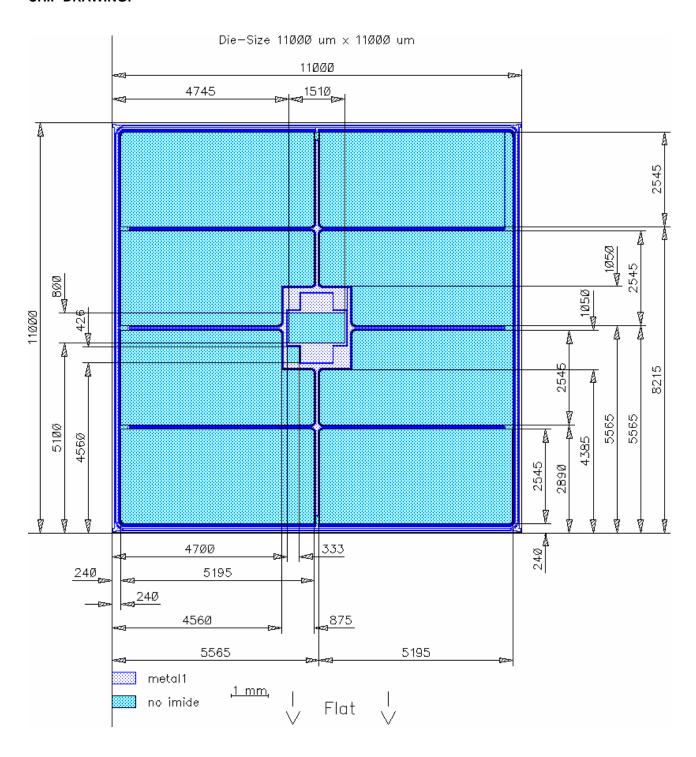
Parameter	Symbol Conditions 1)		Value			Unit
	Symbol	Conditions	min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C	-	125		ns
Rise time	t_{r}	V _{CC} =300V	-	30		
Turn-off delay time	$t_{d(off)}$	I _C =150 A, V _{GE} =-15/15V	-	225		
Fall time	t_{f}	$R_{\rm G}$ =1.5 Ω	-	35		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	BSM 150 GD 60 DLC				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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